

Application Serial No. 10/773,524  
Response to Office Action

Customer No. 01933

Attorney Docket No. 04083/LH

This paper is being submitted via  
EFS-Web on September 29, 2009

**IN THE UNITED STATES PATENT  
AND TRADEMARK OFFICE**

Applicant(s): Takashi YONEYAMA, et al.

Serial No. : 10/773,524

Confirm. No.: 7190

Filed : February 6, 2004

For : DEFECT INSPECTION APPARATUS AND  
DEFECT INSPECTION METHOD

Art Unit : 2624

Examiner : Tsung Yin Tsai

In the event that this Paper is late filed, and the necessary petition for extension of time is not filed concurrently herewith, please consider this as a Petition for the requisite extension of time, and to the extent not already paid, authorization to charge the extension fee to Account No. 06-1378. In addition, authorization is hereby given to charge any fees for which payment has not been submitted, or to credit any overpayments, to Account No. 06-1378.

**A M E N D M E N T**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

S I R :

This is responsive to the Office Action mailed July 6, 2009, the term for response to which expires on October 6, 2009.

**Amendments to the Claims** are set forth in the listing of claims which begins on page 2 of this paper. Claims 1, 5-8, 13-17, 19 and 23 are canceled; claims 9 and 18 are amended; and claims 2-4, 10-12, 20-22 and 24-26 are maintained.

**Remarks** begin on page 11 of this paper.